

Search Notes**Application/Control No.**

09/378,217

Examiner

Chau Nguyen

Applicant(s)/Patent under Reexamination

PHILYAW ET AL.

Art Unit

70

SEARCHED

Class	Subclass	Date	Examiner
709	203	1/11/2006	CN
709	217-219	1/11/2006	CN
709	224	1/11/2006	CN
709	226-227	1/11/2006	CN
709	229	1/11/2006	CN
709	231	1/11/2006	CN
709	238	1/11/2006	CN
709	245	1/11/2006	CN
725	105	1/11/2006	CN
725	109	1/11/2006	CN
725	112	1/11/2006	CN
707	10	1/11/2006	CN
707	104.1	1/11/2006	CN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
709	217-219	1/11/2006	CN
709	2026-227	1/11/2006	CN
709	229,245	1/11/2006	CN
725/105,109,112 707/10,104.1		1/11/2006	CN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated Search on East Reports	1/11/2006	CN
Inventor Search	01/11/2006	CN
NPL Search on IEEE Database	1/11/2006	CN
Discussed with Primary William Bashore	1/10/2006	CN
Interference Search on East Reports	1/12/2005	CN